

## 2N3954, 2N3955, 2N3956

## N-Channel Dual Silicon Junction Field-Effect Transistor

- Low and Medium Frequency Differential Amplifiers
- High Input Impedance Amplifiers

**Absolute maximum ratings at  $T_A = 25^\circ\text{C}$** 

Reverse Gate Source & Reverse Gate Drain Voltage	-50 V
Gate Current	50 mA
Total Device Power Dissipation (each side)	250 mW
@ 85°C Case Temperature (both sides)	500 mW
Power Derating (both sides)	4.3 mW/°C

**At 25°C free air temperature:**  
**Static Electrical Characteristics**

		2N3954		2N3955		2N3956		Process NJ16	
		Min	Max	Min	Max	Min	Max	Unit	Test Conditions
Gate Source Breakdown Voltage	$V_{(\text{BR})\text{GSS}}$	-50		-50		-50		V	$I_G = -1\mu\text{A}, V_{DS} = 0\text{V}$
Gate Reverse Current	$I_{\text{GSS}}$		-100		-100		-100	pA	$V_{GS} = -30\text{V}, V_{DS} = 0\text{V}$
			-500		-500		-500	nA	$V_{GS} = -30\text{V}, V_{DS} = 0\text{V}$
Gate Operating Current	$I_G$		-50		-50		-50	pA	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$
			-250		-250		-250	nA	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$
Gate Source Voltage	$V_{GS}$		-4.2		-4.2		-4.2	V	$V_{DS} = 20\text{V}, I_D = 50\mu\text{A}$
		-0.5	-4	-0.5	-4	-0.5	-4	V	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$
Gate Source Cutoff Voltage	$V_{GS(\text{OFF})}$	-1	-4.5	-1	-4.5	-1	-4.5	V	$V_{DS} = -20\text{V}, I_G = 1\text{nA}$
Gate Source Forward Voltage	$V_{GS(\text{F})}$		2		2		2	V	$V_{DS} = 0\text{V}, I_G = 1\text{mA}$
Drain Saturation Current (Pulsed)	$I_{\text{DSS}}$	0.5	5	0.5	5	0.5	5	mA	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$

**Dynamic Electrical Characteristics**

Common Source Forward Transconductance	$g_{fs}$	1000	3000	1000	3000	1000	3000	$\mu\text{S}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	$f = 1\text{ kHz}$
		1000		1000		1000		$\mu\text{S}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	$f = 200\text{ MHz}$
Common Source Output Capacitance	$C_{os}$		35		35		35	$\mu\text{S}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	$f = 1\text{ kHz}$
Common Source Input Capacitance	$C_{iss}$		4		4		4	$\text{pF}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	$f = 1\text{ MHz}$
Drain Gate Capacitance	$C_{dgo}$		1.5		1.5		1.5	$\text{pF}$	$V_{dg} = 10\text{V}, I_S = 0\text{A}$	$f = 1\text{ MHz}$
Common Source Reverse Transfer Capacitance	$C_{rss}$		1.2		1.2		1.2	$\text{pF}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	$f = 1\text{ MHz}$
Noise Figure	NF		0.5		0.5		0.5	$\text{dB}$	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}, R_g = 10\text{ M}\Omega$	$f = 100\text{ Hz}$
Differential Gate Current	$ I_{G1} - I_{G2} $		10		10		10	nA	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$	$T_A = 125^\circ\text{C}$
Saturation Drain Current Ratio	$I_{\text{DSS1}}/I_{\text{DSS2}}$	0.95	1	0.95	1	0.95	1		$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$	
Differential Gate Source Voltage	$ V_{GS1} - V_{GS2} $		5		10		15	mV	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$	
Differential Gate Source Voltage with Temperature	$\frac{\Delta V_{GS1} - V_{GS2}}{\Delta T}$		0.8		2		4	$\text{mV}/^\circ\text{C}$	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$	$T_A = 25^\circ\text{C}$
			1		2.5		5	$\text{mV}/^\circ\text{C}$	$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$	$T_A = 25^\circ\text{C}$ to = +125°C
Transconductance Ratio	$g_{fs1}/g_{fs2}$	0.97	1	0.97	1	0.97	1		$V_{DS} = 20\text{V}, I_D = 200\mu\text{A}$	$f = 1\text{ kHz}$

**TO-71 Package**

See Section G for Outline Dimensions

**Pin Configuration**1 Source, 2 Drain, 3 Gate,  
5 Source, 6 Drain, 7 Gate